Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/628,467	KAWAMURA ET AL.	
Examiner	Art Unit	
Apu M. Mofiz	2165	

	SEARCHED					
Class	Subdass	Date		Examiner		
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717	200					
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INT	INTERFERENCE SEARCHED						
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707	104-1	01/03/05	An				
707	100	01/03/05	An				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
Inventor Seach	01/06/05	An			
Ent - USPAT - USPAPUR - USPAPUR - EPO_ JPD - IBM TIB - DERWENT	09/07/05				
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